

Search Notes

Application/Control No.

10/520,169

Examiner

Shin-Lin Chen

Applicant(s)/Patent under
Reexamination

BACON ET AL.

Art Unit

1632

SEARCHED

Class	Subclass	Date	Examiner
Updated		10/23/2006	<i>SLC</i>

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated	10/23/2006	<i>SLC</i>